

## SSC8048GN4

## **N-Channel Enhancement Mode MOSFET**

#### > Features

V <sub>DS</sub>	V <sub>GS</sub>	R <sub>DS(ON)</sub> Typ.	I <sub>D</sub>
40V	1.201/	7.5mΩ@10V	404
	±20V	9.2mΩ@4V5	40A

## Description

This device is N-Channel enhancement MOSFET.

Uses advanced trench technology and design to provide excellent RDSON with low gate charge. This device is suitable for use in DC-DC conversion, power switch and charging circuit.

#### 100% UIS + $\Delta VDS$ + Rg Tested!

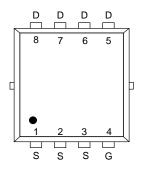
## Applications

- Motor Drive Control
- Portable Devices
- DCDC Conversion
- Power Supplies
- Synchronous Rectification

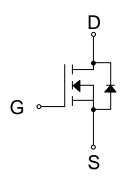
## Ordering Information

Device	Package	Shipping	
SSC8048GN4	PDFN3.3X3.3-8L	5000/Reel	

## Pin Configuration



PDFN3.3X3.3-8L (Top View)



**Pin Configuration** 



**Marking** 

(XXYY: Internal Traceability Code)



## ➤ Absolute Maximum Ratings (T<sub>A</sub>=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit	
V <sub>DSS</sub>	Drain-to-Source Voltage		40	V
V <sub>GSS</sub>	Gate-to-Source Volta	Gate-to-Source Voltage		V
	In Continuous Drain Current d	T <sub>C</sub> =25℃	40	^
ID		T <sub>C</sub> =100°C	22	Α
	Continuous Drain Current <sup>a</sup>	T <sub>A</sub> =25℃	15	^
IDSM		T <sub>A</sub> =70℃	11	A
Ірм	Pulsed Drain Current <sup>b</sup>		150	Α
	Power Dissipation <sup>c</sup>	Tc=25℃	25	34/
P <sub>D</sub>		T <sub>C</sub> =100℃	10	W
Б	Power Dissipation <sup>a</sup>	T <sub>A</sub> =25℃	3.1	34/
P <sub>DSM</sub>		T <sub>A</sub> =70℃	2	W
las	Avalanche Energy <sup>b</sup> L=0.5mH Single Pulse		16	Α
Eas	Avalanche Energy <sup>b</sup> L=0.5mH Single Pulse		64	mJ
TJ	Operation junction temperature		-55~150	%
TstG	Storage temperature ra	-55~150	$^{\circ}$	

## ➤ Thermal Resistance Ratings (T<sub>A</sub>=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
Reja	Junction-to-Ambient Thermal Resistance a	40	°C/W
$R_{ heta JC}$	Junction-to-Case Thermal Resistance	5	C/VV

#### Note:

- a. The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz.copper, in a still air environment with T<sub>A</sub>=25°C. The value in any given application depends on the user is specific board design. The power dissipation is based on the t≤10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.
- d. The maximum current rating is package limited.

SSC-V1.0 www.sscsemi.com Analog Future



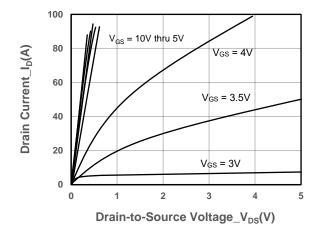


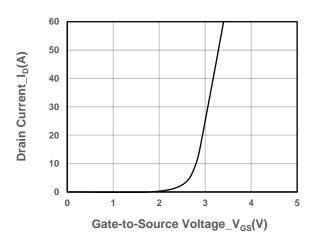
# $\succ$ Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250µA	40			V	
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = 250uA$	1	1.5	2.5	V	
Drain-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10V, I <sub>D</sub> = 20A		7.5	9.7	m0	
Drain-Source On-Resistance		V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 10A		9.2	12	mΩ	
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 40V, V <sub>GS</sub> = 0V			1	μA	
Gate-Source Leak Current	Igss	V <sub>GS</sub> = ±20V, V <sub>DS</sub> = 0V			±100	nA	
Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0V, I <sub>S</sub> = 20A			1.3	V	
Input Capacitance	Ciss	V 00V V 0V		2400			
Output Capacitance	Coss	$V_{DS} = 20V$ , $V_{GS} = 0V$ , $f = 1MHz$		160		pF	
Reverse Transfer Capacitance	Crss	T - TIVINZ		146			
Total Gate Charge	$Q_{\mathrm{G}}$	V - 40V V - 00V		47			
Gate to Source Charge	Q <sub>GS</sub>	V <sub>GS</sub> = 10V, V <sub>DS</sub> = 20V,		9		nC	
Gate to Drain Charge	Q <sub>GD</sub>	I <sub>D</sub> = 10A		10			
Turn-on Delay Time	T <sub>D(ON)</sub>			10			
Rise Time	Tr	$V_{GS} = 10V, V_{DS} = 20V,$		26			
Turn-off Delay Time	$T_{D(OFF)}$	$I_D = 10A, R_G = 3\Omega$		39		ns	
Fall Time	T <sub>f</sub>			7			
Diode Recovery Time	Trr	I <sub>F</sub> =20A, di/dt=100A/us		11		ns	
Diode Recovery Charge	Qrr	I⊧=20A, di/dt=100A/us		4		nC	



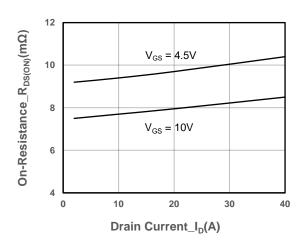
## ➤ Typical Performance Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

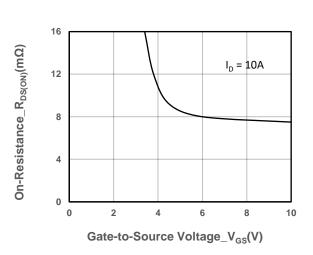




#### **Output Characteristics**

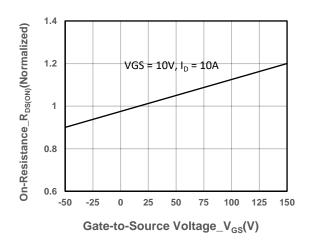
**Transfer Characteristics** 

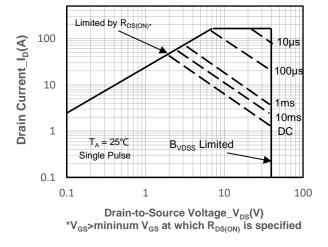




#### On-Resistance vs. Drain Current and Gate Voltag

On-Resistance vs. Gate-to-Source Voltage



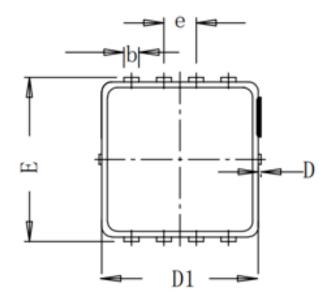


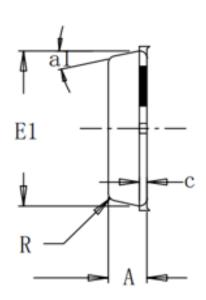
**On-Resistance vs. Junction Temperature** 

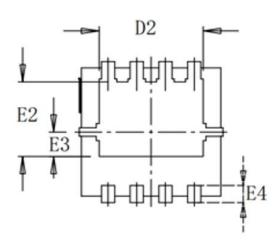
Safe Operating Area vs. Junction-to-Ambient



# Package Information







Cumbal	Dimensions In Millimeters			
Symbol	Min.	Nom.	Max.	
Α	0.75	0.78	0.81	
b	0.297	0.3	0.35	
С	-	0.152	•	
D	0	0.05	0.1	
D1	3.12	3.15	3.18	
D2	-	2.35	-	
E	3.2	3.3	3.4	
E1	3.09	3.12	3.15	
E2	-	1.75	-	
E3	-	0.575	-	
E4	-	0.4	-	
R	-	0.15	•	
е	0.65BSC			
a1°	-	12°	-	



#### **DISCLAIMER**

SSCSEMI RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION OR DESIGN. SSCSEMI DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICIENCE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS.

THE GRAPHS PROVIDED IN THIS DOCUMENT ARE STATISTICAL SUMMARIES BASED ON A LIMITED NUMBER OF SAMPLES AND ARE PROVIDED FOR INFORMATIONAL PURPOSE ONLY. THE PERFORMANCE CHARACTERISTICS LISTED IN THEM ARE NOT TESTED OR GUARANTEED. IN SOME GRAPHS, THE DATA PRESENTED MAY BE OUTSIDE THE SPECIFIED OPERATING RANGE (E.G. OUTSIDE SPECIFIED POWER SUPPLY RANGE) AND THEREFORE OUTSIDE THE WARRANTED RANGE.

OUR PRODUCT SPECIFICATIONS ARE ONLY VALID IF OBTAINED THROUGH THE COMPANY'S OFFICIAL WEBSITE, CRM SYSTEM, OR OUR SALES PERSONNEL CHANNELS. IF CHANGES OR SPECIAL VERSIONS ARE INVOLVED, THEY MUST BE STAMPED WITH A QUALITY SEAL AND MARKED WITH A SPECIAL VERSION NUMBER TO BE VALID.